

<b>Notice of References Cited</b>	Application/Control No. 10/618,749		Applicant(s)/Patent Under Reexamination MUTSURO ET AL.	
	Examiner Chriss S. Yoder, III		Art Unit 2622	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,331,872 B1	12-2001	Hyuga, Makoto	348/211.1
*	B	US-2002/0101519	08-2002	Myers, Jeffrey S.	348/232
*	C	US-6,919,920 B2	07-2005	Squilla et al.	348/207.99
*	D	US-6,819,867 B2	11-2004	Mayer et al.	396/56
*	E	US-2002/0149681 A1	10-2002	Kahn et al.	348/211.99
*	F	US-6,937,154 B2	08-2005	Zeps et al.	340/573.1
*	G	US-2002/0008622	01-2002	Weston et al.	340/572.1
*	H	US-2004/0105008 A1	06-2004	Yamazaki, Akihisa	348/207.1
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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